



STGW35HF60W

35 A, 600 V ultra fast IGBT

Preliminary data

Features

- Improved E_{off} at elevated temperature
- Minimal tail current
- Low conduction losses
- $V_{CE(sat)}$ classified for easy parallel connection

Applications

- Welding
- High frequency converters
- Power factor correction

Description

The STGW35HF60W is based on a new advanced planar technology concept to yield an IGBT with more stable switching performance (E_{off}) versus temperature, as well as lower conduction losses. The device is tailored to high switching frequency operation (over 100 kHz).

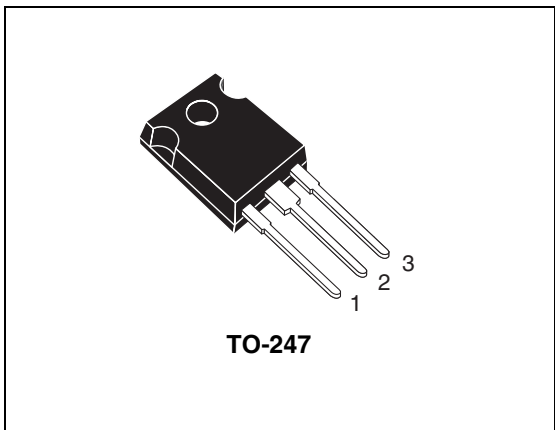


Figure 1. Internal schematic diagram

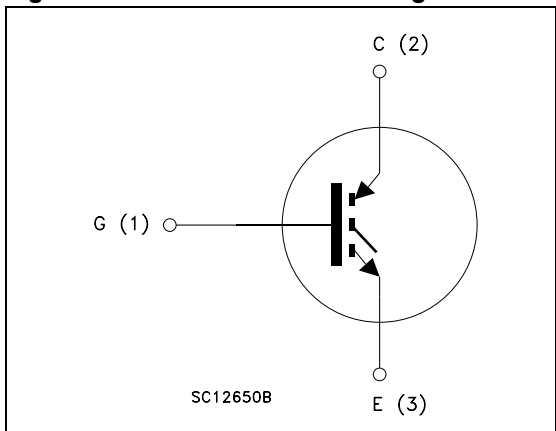


Table 1. Device summary

| Order code | Marking ⁽¹⁾ | Package | Packaging |
|-------------|------------------------|---------|-----------|
| STGW35HF60W | GW35HF60WA | TO-247 | Tube |
| | GW35HF60WB | | |
| | GW35HF60WC | | |

1. Collector-emitter saturation voltage is classified in group A, B and C, see [Table 5: \$V_{CE\(sat\)}\$ classification](#). STMicroelectronics reserves the right to ship from any group according to production availability.

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|-------------|------|
| V_{CES} | Collector-emitter voltage ($V_{GE} = 0$) | 600 | V |
| $I_C^{(1)}$ | Continuous collector current at $T_C = 25\text{ °C}$ | 60 | A |
| $I_C^{(1)}$ | Continuous collector current at $T_C = 100\text{ °C}$ | 35 | A |
| $I_{CP}^{(2)}$ | Pulsed collector current | 150 | A |
| $I_{CL}^{(3)}$ | Turn-off latching current | 80 | A |
| V_{GE} | Gate-emitter voltage | ± 20 | V |
| P_{TOT} | Total dissipation at $T_C = 25\text{ °C}$ | 200 | W |
| T_{stg} | Storage temperature | – 55 to 150 | °C |
| T_j | Operating junction temperature | | |

1. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{j(max)} - T_C}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_C(T_C))}$$

2. Pulse width limited by maximum junction temperature and turn-off within RBSOA

3. $V_{CLAMP} = 80\% (V_{CES})$, $V_{GE} = 15\text{ V}$, $R_G = 10\text{ }\Omega$, $T_J = 150\text{ °C}$

Table 3. Thermal data

| Symbol | Parameter | Value | Unit |
|----------------|-------------------------------------|-------|------|
| $R_{thj-case}$ | Thermal resistance junction-case | 0.63 | °C/W |
| $R_{thj-amb}$ | Thermal resistance junction-ambient | 50 | °C/W |

2 Electrical characteristics

($T_J = 25\text{ °C}$ unless otherwise specified)

Table 4. Static

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|--|------|------|-----------|---------------|
| $V_{(BR)CES}$ | Collector-emitter breakdown voltage ($V_{GE} = 0$) | $I_C = 1\text{ mA}$ | 600 | | | V |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}, I_C = 20\text{ A}$ | | | 2.5 | V |
| | | $V_{GE} = 15\text{ V}, I_C = 20\text{ A}, T_J = 125\text{ °C}$ | | 1.65 | | |
| $V_{GE(th)}$ | Gate threshold voltage | $V_{CE} = V_{GE}, I_C = 1\text{ mA}$ | 3.75 | | 5.75 | V |
| I_{CES} | Collector cut-off current ($V_{GE} = 0$) | $V_{CE} = 600\text{ V}$ | | | 250 | μA |
| | | $V_{CE} = 600\text{ V}, T_J = 125\text{ °C}$ | | | 1 | mA |
| I_{GES} | Gate-emitter leakage current ($V_{CE} = 0$) | $V_{GE} = \pm 20\text{ V}$ | | | ± 100 | nA |

Table 5. $V_{CE(sat)}$ classification

| Symbol | Parameter | Group | Value | | Unit |
|---------------|---|-------|-------|------|------|
| | | | Min. | Max. | |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage $V_{GE} = 15\text{ V}, I_C = 20\text{ A}$ | A | 1.68 | 1.92 | V |
| | | B | 1.88 | 2.17 | |
| | | C | 2.13 | 2.50 | |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|------|
| C_{ies} | Input capacitance | $V_{CE} = 25\text{ V}, f = 1\text{ MHz},$ $V_{GE} = 0$ | - | 2400 | - | pF |
| C_{oes} | Output capacitance | | | 235 | | pF |
| C_{res} | Reverse transfer capacitance | | | 50 | | pF |
| Q_g | Total gate charge | $V_{CE} = 400\text{ V}, I_C = 20\text{ A},$ $V_{GE} = 15\text{ V},$ (see Figure 16) | - | 140 | - | nC |
| Q_{ge} | Gate-emitter charge | | | 13 | | nC |
| Q_{gc} | Gate-collector charge | | | 52 | | nC |

Table 7. Switching on/off (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|-----------------------|--|------|------|------|------------|
| $t_{d(on)}$ | Turn-on delay time | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$ | | 30 | | ns |
| t_r | Current rise time | $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, | - | 15 | - | ns |
| $(di/dt)_{on}$ | Turn-on current slope | (see Figure 15) | | 1650 | | A/ μ s |
| $t_{d(on)}$ | Turn-on delay time | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$ | | 30 | | ns |
| t_r | Current rise time | $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, | - | 15 | - | ns |
| $(di/dt)_{on}$ | Turn-on current slope | $T_J = 125\text{ }^\circ\text{C}$ (see Figure 15) | | 1600 | | A/ μ s |
| $t_r(V_{off})$ | Off voltage rise time | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$, | | 30 | | ns |
| $t_{d(off)}$ | Turn-off delay time | $R_{GE} = 10\ \Omega$, $V_{GE} = 15\text{ V}$ | - | 175 | - | ns |
| t_f | Current fall time | (see Figure 15) | | 40 | | ns |
| $t_r(V_{off})$ | Off voltage rise time | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$, | | 50 | | ns |
| $t_{d(off)}$ | Turn-off delay time | $R_{GE} = 10\ \Omega$, $V_{GE} = 15\text{ V}$, | - | 225 | - | ns |
| t_f | Current fall time | $T_J = 125\text{ }^\circ\text{C}$ (see Figure 15) | | 70 | | ns |

Table 8. Switching energy (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|---------------------------|--|------|------|------|---------|
| $E_{on}^{(1)}$ | Turn-on switching losses | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$ | | 290 | | μ J |
| E_{off} | Turn-off switching losses | $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, | - | 185 | | μ J |
| E_{ts} | Total switching losses | (see Figure 17) | | 475 | | μ J |
| $E_{on}^{(1)}$ | Turn-on switching losses | $V_{CC} = 400\text{ V}$, $I_C = 20\text{ A}$ | | 420 | | μ J |
| E_{off} | Turn-off switching losses | $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, | - | 350 | 530 | μ J |
| E_{ts} | Total switching losses | $T_J = 125\text{ }^\circ\text{C}$ (see Figure 17) | | 770 | | μ J |

1. E_{on} is the turn-on losses when a typical diode is used in the test circuit in [Figure 17](#). If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs and diode are at the same temperature (25 °C and 125 °C). E_{on} include diode recovery energy.

2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

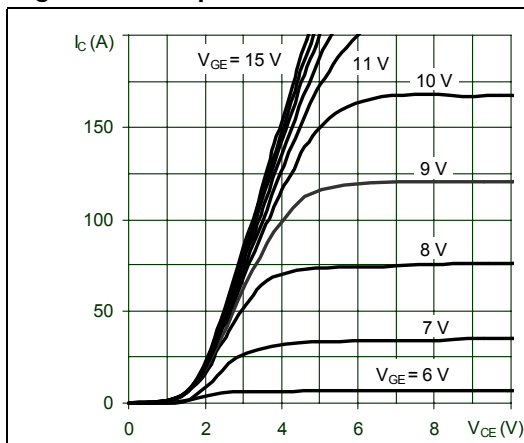


Figure 3. Transfer characteristics

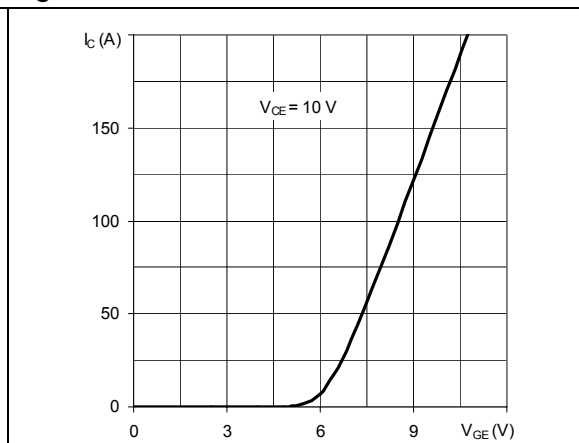
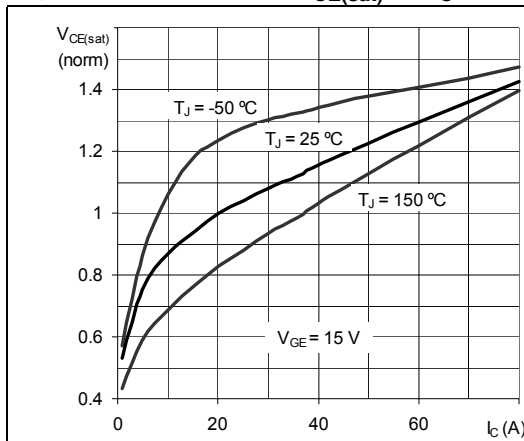
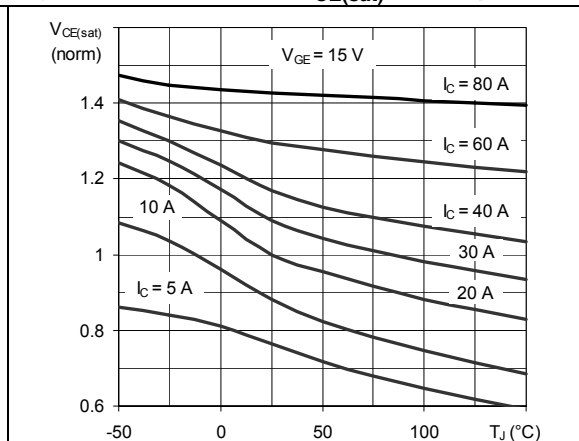
Figure 4. Normalized $V_{CE(sat)}$ vs. I_C Figure 5. Normalized $V_{CE(sat)}$ vs. temperature

Figure 6. Normalized breakdown voltage vs. temperature

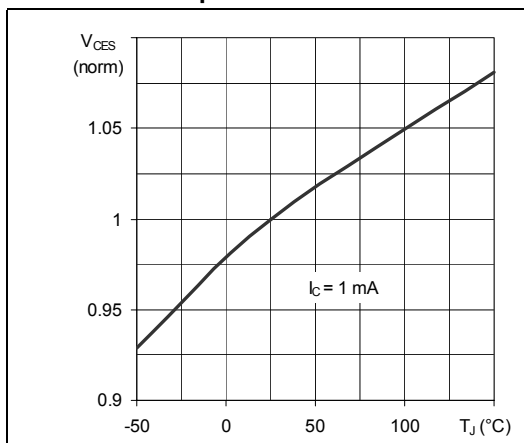


Figure 7. Normalized gate threshold voltage vs. temperature

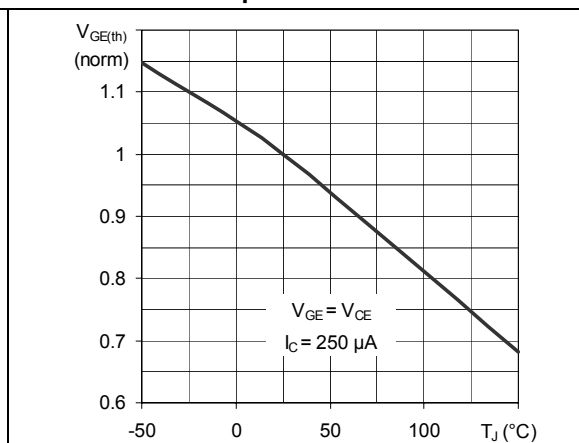


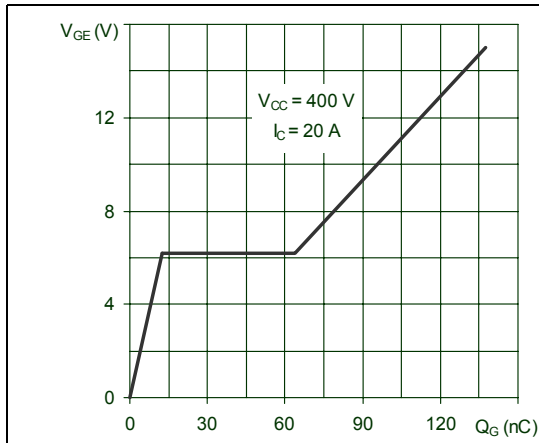
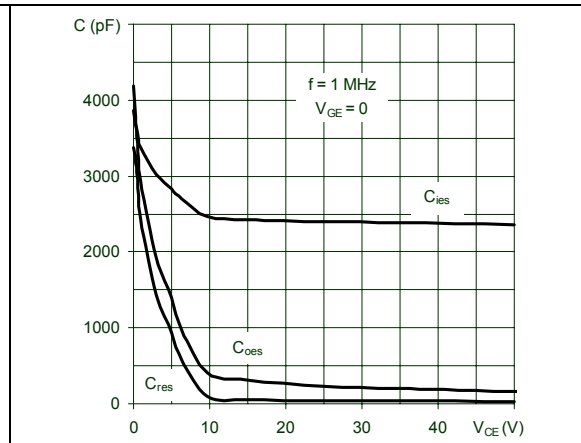
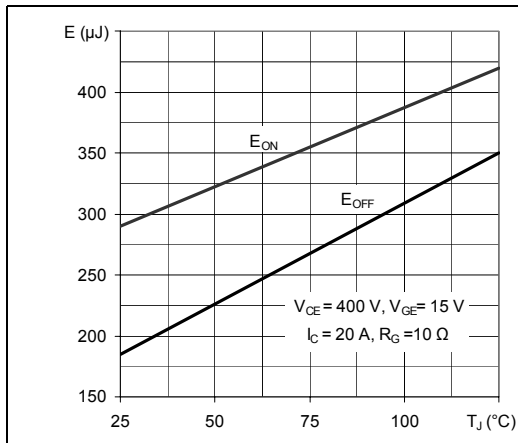
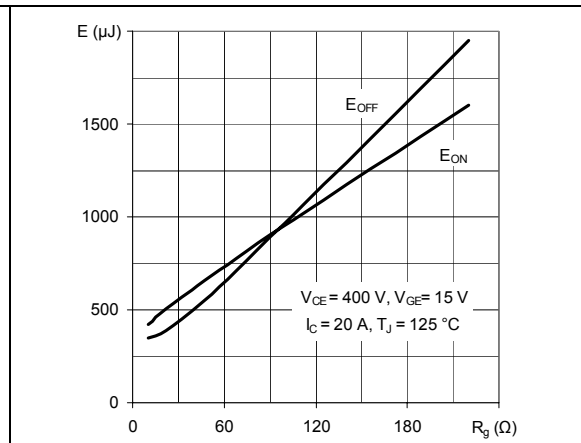
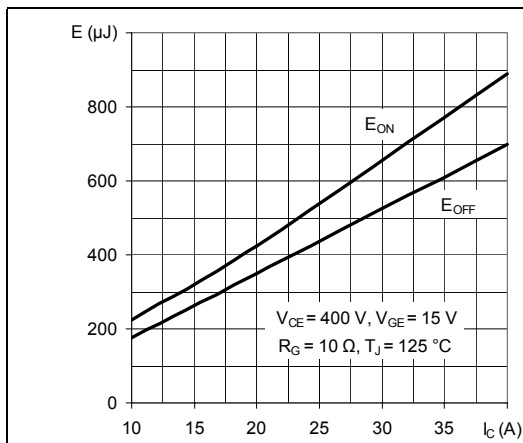
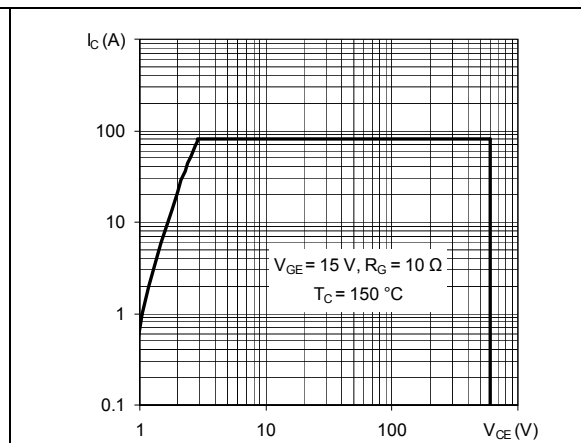
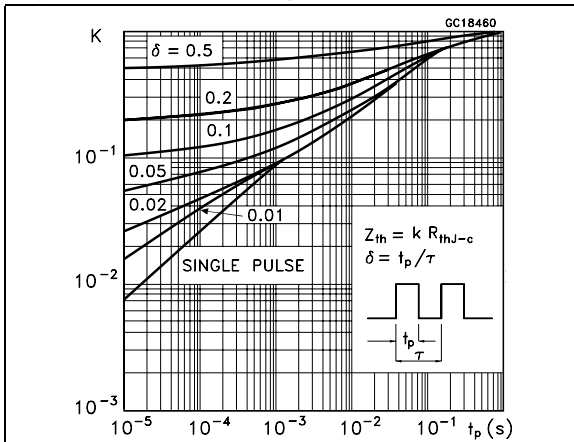
Figure 8. Gate charge vs. gate-emitter voltage**Figure 9. Capacitance variations****Figure 10. Switching losses vs temperature****Figure 11. Switching losses vs. gate resistance****Figure 12. Switching losses vs. collector current****Figure 13. Turn-off SOA**

Figure 14. Thermal impedance



3 Test circuits

Figure 15. Test circuit for inductive load switching

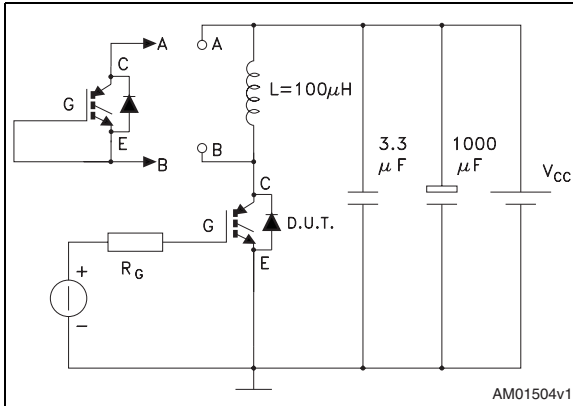


Figure 16. Gate charge test circuit

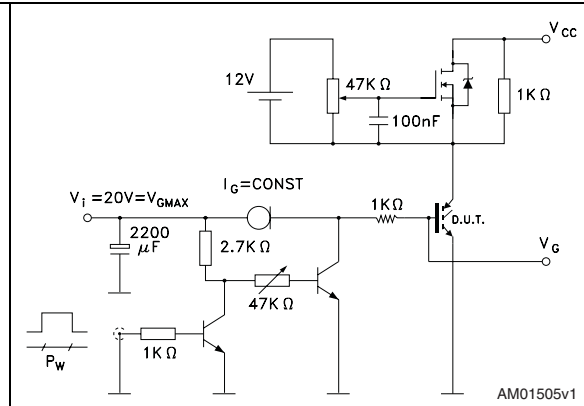
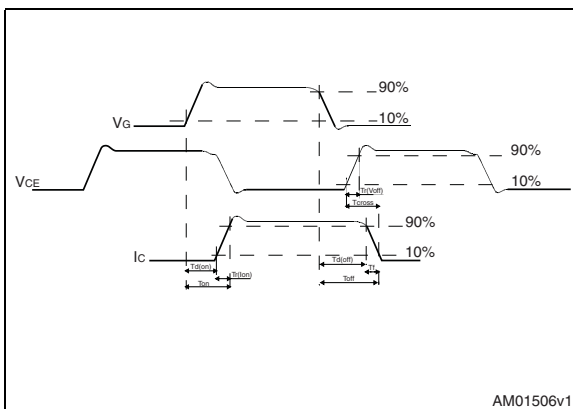


Figure 17. Switching waveform

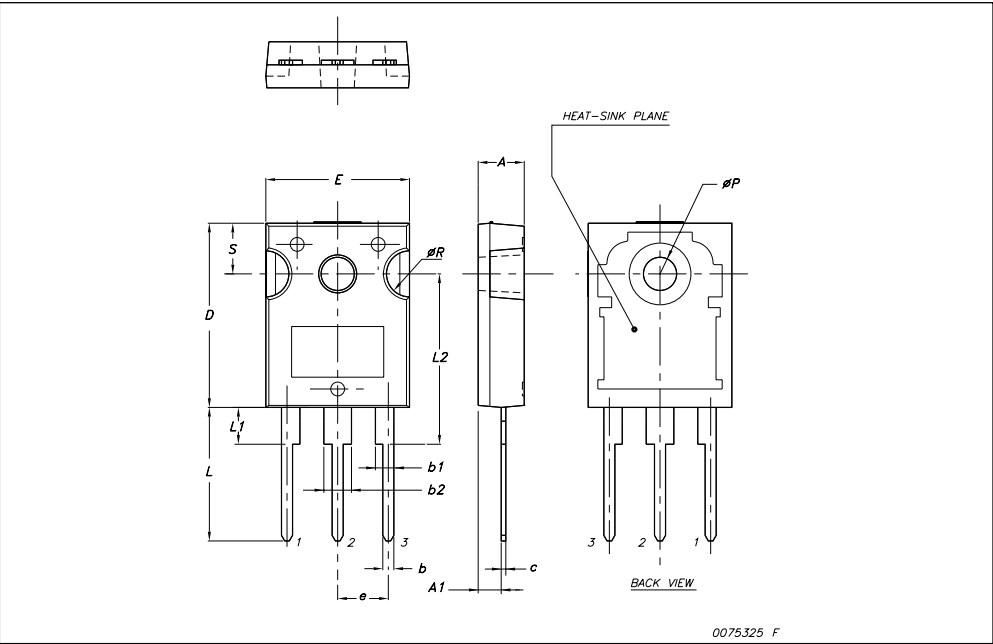


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

TO-247 Mechanical data

| Dim. | mm. | | |
|------|-------|-------|-------|
| | Min. | Typ | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | | 5.45 | |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| øP | 3.55 | | 3.65 |
| øR | 4.50 | | 5.50 |
| S | | 5.50 | |



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|-----------------|
| 17-May-2010 | 1 | Initial release |

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2010 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com